

Certified Reference Material

Certificate of Analysis

Product ID: IARM Fe4140-19

ISO
17034:2016

ISO/IEC
17025:2017

ISO
9001:2015

Product Description: Alloy Steel, Cr/Mo AISI 4140 / G41400

Revision No.: 000
Revision Date: 02/25/2022

Description and Intended Use: This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Certified Values listed in wt.% with associated uncertainties											
Al	0.031	± 0.008	As	0.005	± 0.002	C	0.401	± 0.004	Co	0.009	± 0.002
Cr	1.1	± 0.2	Cu	0.23	± 0.05	Mn	0.9	± 0.2	Mo	0.17	± 0.04
N	0.0110	± 0.0004	Ni	0.14	± 0.03	P	0.008	± 0.002	S	0.022	± 0.008
Sb	0.004	± 0.002	Si	0.22	± 0.05	Sn	0.010	± 0.002	Ti	0.0009	± 0.0003
V	0.0030	± 0.0005	W	0.003	± 0.002						

Indicative Values listed in ppm							
B (5)	Fe (97.3%)	Mg (<50)	Nb (20)	O (40)	Pb (10)	Zn (<30)	
Zr (10)							

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculate uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where $H=U_{hom}$, S = Standard deviation, t = t-value at 95% CI, and n = number of observations.

$$1. N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$

$$2. U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognized reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- LGC Standards - Manchester, NH
- Connecticut Metallurgical, Inc. - East Hartford, CT
- IMR Test Labs - Lansing, NY
- NSL Analytical Services - Cleveland, OH
- SGS MSI - Melrose Park, IL
- Cleveland Cliffs - Middletown, OH
- Applied Technical Services - Marietta, GA
- EAG Laboratories - Liverpool, NY
- Sheffield Assay Office - Sheffield, UK
- Scrooby's Laboratory Service - Rynfield, South Africa
- Element Materials Technology - Middlesbrough, UK
- New Hampshire Materials Laboratory - Somersworth, NH
- RSML - Bengaluru, India
- IMR Test Labs - Louisville, KY

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.


Kimberly Halotis, Global Product Manager

February 25, 2022
Certification Date



ISO 17034 Accredited: Reference Materials
Producer, Certificate # 2848.02
ISO/IEC 17025 Accredited: Chemical
Testing, Certificate # 2848.01

Conditions of Sale and Supply: All CRMs & RMs sold are subject to applicable LGC Standard Terms and Conditions of Sale.



The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Al	As	B	C	Co	Cr	Cu	Fe	Mg	Mn	Mo	N	Nb
1	0.0295	0.0030	0.0003	0.3910	0.0070	1.0130	0.2180	96.710	0.0016	0.8900	0.1640	0.0100	0.0010
2	0.0300	0.0035	0.0003	0.3910	0.0070	1.0283	0.2193	96.993	0.0360	0.8930	0.1640	0.0107	0.0010
3	0.0300	0.0043	0.0004	0.3923	0.0077	1.0325	0.2258	97.050	<0.00005	0.9000	0.1660	0.0108	0.0014
4	0.0300	0.0050	0.0005	0.3940	0.0080	1.0330	0.2260	97.220	<0.0005	0.9000	0.1660	0.0109	0.0016
5	0.0302	0.0050	0.0010	0.3990	0.0080	1.0482	0.2260	98.440	<0.001	0.9018	0.1677	0.0110	0.0020
6	0.0309	0.0054	<0.00005	0.3996	0.0080	1.0494	0.2277		<0.001	0.9110	0.1680	0.0114	0.0025
7	0.0310	0.0054	<0.0001	0.4010	0.0083	1.0500	0.2300		<0.0010	0.9129	0.1680	0.0114	<0.00005
8	0.0310	0.0059	<0.0004	0.4010	0.0086	1.0530	0.2300		<0.0010	0.9140	0.1690	0.0117	<0.0005
9	0.0311	0.0060	<0.0005	0.4016	0.0086	1.0560	0.2323		<0.002	0.9150	0.1690		<0.001
10	0.0313	0.0061	<0.001	0.4020	0.0086	1.0560	0.2326		<0.002	0.9170	0.1698		<0.001
11	0.0313	0.0065	<0.001	0.4030	0.0088	1.0589	0.2330		<0.003	0.9180	0.1700		<0.0010
12	0.0320	0.0066	<0.0010	0.4030	0.0090	1.0590	0.2340		<0.005	0.9181	0.1700		<0.002
13	0.0332	0.0069	<0.005	0.4080	0.0091	1.0600	0.2340			0.9200	0.1711		<0.002
14		<0.002		0.4082	0.0100	1.0640	0.2353			0.9210	0.1720		<0.002
15		<0.002		0.4130	0.0100	1.0640	0.2400			0.9280	0.1740		<0.0020
16					0.0101	1.0650	0.2410			0.9358	0.1740		<0.005
17					<0.0005	1.0800	0.2420				0.1767		<0.01
18					<0.001		0.2450						<0.01
19							0.2500						
20													
Mean	0.0309	0.0054	0.0005	0.4005	0.0086	1.0512	0.2327	97.283	0.0188	0.9122	0.1694	0.0110	0.0016
STDV	0.0010	0.0012	0.0003	0.0064	0.0010	0.0163	0.0083	0.6725	0.0243	0.0124	0.0035	0.0005	0.0006
Certified	0.031	0.005	(0.0005)	0.401	0.009	1.1	0.23	(97.3)	(<0.005)	0.9	0.17	0.011	(0.002)
U _{CRM}	0.008	0.002		0.004	0.002	0.2	0.05			0.2	0.04	0.0004	
Methods	O,I,G,IM,X	IM,O,I,X	IM,O,I	C,G,O	IM,O,I,X	O,I,G,X	O,I,IM,X	O,I,X	IM,O,I,X	O,I,X	O,I,IM,X	F,O	IM,O,I,G,X

	Ni	O	P	Pb	S	Sb	Si	Sn	Ti	V	W	Zn	Zr
1	0.1300	0.0010	0.0056	0.0003	0.0179	0.0020	0.1930	0.0090	0.0004	0.0023	0.0008	0.0006	0.0002
2	0.1340	0.0009	0.0059	0.0006	0.0181	0.0020	0.2000	0.0090	0.0004	0.0013	0.0009	0.0030	0.0018
3	0.1369	0.0012	0.0060	0.0012	0.0200	0.0021	0.2056	0.0090	0.0005	0.0016	0.0012		0.0019
4	0.1370	0.0017	0.0070	0.0031	0.0202	0.0023	0.2079	0.0096	0.0007	0.0023	0.0020		0.0019
5	0.1380	0.0091	0.0070	<0.00005	0.0214	0.0027	0.2093	0.0097	0.0009	0.0030	0.0025		<0.00005
6	0.1380	0.0120	0.0072	<0.0001	0.0220	0.0028	0.2110	0.0097	0.0010	0.0031	0.0040		<0.0005
7	0.1390	<0.002	0.0080	<0.001	0.0226	0.0029	0.2120	0.0098	0.0010	0.0031	0.0043		<0.001
8	0.1410		0.0084	<0.001	0.0228	0.0060	0.2150	0.0100	0.0010	0.0031	0.0043		<0.001
9	0.1410		0.0086	<0.0010	0.0229	0.0063	0.2180	0.0100	0.0010	0.0033	0.0049		<0.0010
10	0.1416		0.0088	<0.0010	0.0230	0.0063	0.2180	0.0100	0.0013	0.0036	0.0050		<0.0010
11	0.1420		0.0088	<0.002	0.0230	<0.0010	0.2183	0.0100	0.0020	0.0040	0.0050		<0.002
12	0.1435		0.0090	<0.002	0.0234	<0.002	0.2220	0.0101	<0.0005	0.0040	0.0050		<0.002
13	0.1440		0.0090	<0.002	0.0240	<0.002	0.2240	0.0103	<0.001	0.0040	<0.0005		<0.005
14	0.1440		0.0091	<0.005		<0.002	0.2260	0.0103	<0.001	<0.001	<0.001		
15	0.1440		0.0094	<0.01		<0.005	0.2300	0.0104	<0.0010	<0.002	<0.001		
16	0.1450		0.0095			<0.005	0.2400	0.0108	<0.002	<0.002	<0.0010		
17	0.1460		0.0097					0.0110	<0.002	<0.005	<0.002		
18	0.1530		0.0100					0.0120	<0.002	<0.01	<0.002		
19			0.0110						<0.005		<0.005		
20			<0.002								<0.01		
Mean	0.1410	0.0043	0.0083	0.0013	0.0216	0.0035	0.2156	0.0100	0.0009	0.0030	0.0033	0.0018	0.0015
STDV	0.0051	0.0049	0.0015	0.0013	0.0020	0.0019	0.0116	0.0007	0.0005	0.0009	0.0017	0.0017	0.0008
Certified	0.14	(0.004)	0.008	(0.001)	0.022	0.004	0.22	0.01	0.0009	0.003	0.003	(<0.003)	(0.001)
U _{CRM}	0.03		0.002		0.008	0.002	0.05	0.002	0.0003	0.0005	0.002		
Methods	O,I,IM,X	F	IM,O,I,G,X	IM,O,I,X	C,O,I	IM,O,I,X	I,G,IM,O,X	IM,O,I,X	IM,O,I,G,X	IM,O,I,G,X	IM,O,I,G,X	I	IM,O,I,X

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

